onsemi

MOSFET – N-Channel, Shielded Gate, POWERTRENCH[®]

100 V, 20 A, 24 m Ω

FDMC86102

General Description

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

Features

- Shielded Gate MOSFET Technology
- Max $R_{DS(on)} = 24 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 7\text{A}$
- Max $R_{DS(on)} = 38 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 5 \text{ A}$
- Low Profile 1 mm max in Power 33
- 100% UIL Tested
- This Device is Pb-Free, Halide Free and is RoHS Compliant

Applications

• DC-DC Conversion

MAXIMUM RATINGS (T_A = 25°C unless otherwise specified)

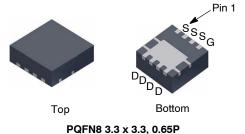
Symbol	Parameter	Ratings	Unit
V _{DS}	Drain to Source Voltage	100	V
V _{GS}	Gate to Source Voltage	±20	V
Ι _D	Drain Current – Continuous T _C = 25°C	20	A
	– Continuous T _A = 25°C (Note 1a)	7	
	– Pulsed (Note 4)	60	
E _{AS}	Single Pulse Avalanche Energy (Note 3)	72	mJ
PD	Power Dissipation $T_C = 25^{\circ}C$	41	W
	Power Dissipation $T_A = 25^{\circ}C$ (Note 1a)	2.3	
T _J , T _{STG}	Operating and Storage Junction Temperature Range	–55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

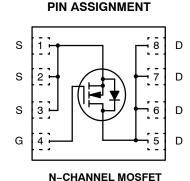
THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	





PQFN8 3.3 x 3.3, 0.65 CASE 483AK



N-CHANNEL MOSFEI



Z X

YY

KK

FDMC86102



= Weekly Code

= Lot Code

= Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
FDMC86102	PQFN8 (Pb-Free, Halide Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, <u>BRD8011/D</u>.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

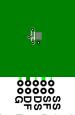
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS	-	•		•	
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	100	-	-	V
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta \text{T}_{\text{J}}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25°C	-	69	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	-	±100	nA
ON CHARA	ACTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$	2.0	3.1	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 µA, referenced to 25°C	-	-9	-	mV/°C
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 7 A	-	19.4	24	mΩ
		V _{GS} = 6 V, I _D = 5 A	-	26.8	38	
		V_{GS} = 10 V, I _D = 7 A, T _J = 125°C	-	32.8	41	1
9 FS	Forward Transconductance	V _{DS} = 10 V, I _D = 7 A	-	19	-	S
OYNAMIC	CHARACTERISTICS					
C _{iss}	Input Capacitance	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	725	965	pF
C _{oss}	Output Capacitance	1	-	175	235	pF
C _{rss}	Reverse Transfer Capacitance	1	-	15	25	pF
Rg	Gate Resistance		-	0.5	-	Ω
WITCHIN	G CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 50 \text{ V}, \text{ I}_{D} = 7 \text{ A},$	-	8	17	ns
t _r	Rise Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	_	4	10	1
t _{d(off)}	Turn-Off Delay Time	7	_	14	25	1
t _f	Fall Time		-	4	10	
Q _{g(TOT)}	Total Gate Charge	V_{GS} = 0 V to 10 V, V_{DD} = 50 V, I_{D} = 7 A	-	13	18	nC
Q _{g(TOT)}	Total Gate Charge	V_{GS} = 0 V to 5 V, V_{DD} = 50 V, I_{D} = 7 A	-	8	11	
Q _{gs}	Total Gate Charge	$V_{DD} = 50 \text{ V}, \text{ I}_{D} = 7 \text{ A}$	-	3.7	-	nC
Q _{gd}	Gate to Drain "Miller" Charge		_	3.6	-	
RAIN-SO	URCE DIODE CHARACTERISTICS					
V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 7 A (Note 2)	-	0.81	1.3	V
		V _{GS} = 0 V, I _S = 2 A (Note 2)	-	0.75	1.2	V

		V _{GS} = 0 V, I _S = 2 A (Note 2)	-	0.75	1.2	V
t _{rr}	Reverse Recovery Time	I _F = 7 A, di/dt = 100 A/μs	-	44	70	ns
Q _{rr}	Reverse Recovery Charge		-	40	65	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 53°C/W when mounted on a 1 in² pad of 2 oz copper



b) 125°C/W when mounted on a minimum pad of 2 oz copper

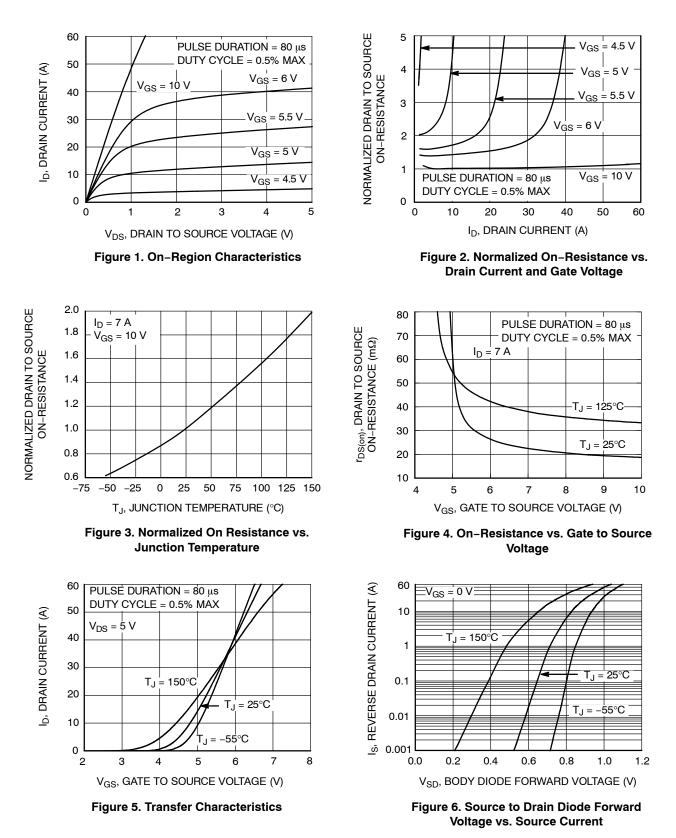
2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. Starting T_J = 25°C; N-ch: L = 1 mH, I_{AS} = 12 A, V_{DD} = 90 V, V_{GS} = 10 V. 4. Pulse Id refers to Figure.11 Forward Bias Safe Operation Area.

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TYPICAL CHARACTERISTICS

(T_J = 25°C unless otherwise noted)



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TYPICAL CHARACTERISTICS (continued)

(T_J = 25°C unless otherwise noted)

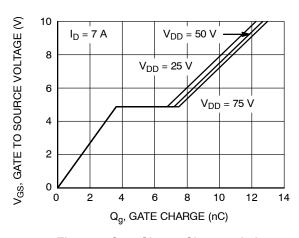


Figure 7. Gate Charge Characteristics

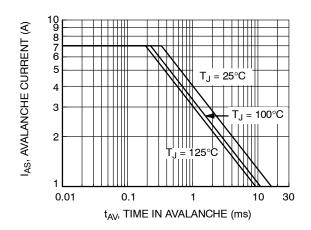
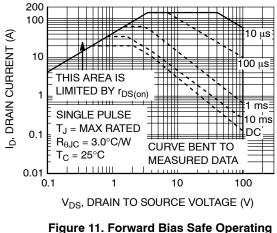


Figure 9. Unclamped Inductive Switching Capability



gure 11. Forward Bias Safe Operating Area

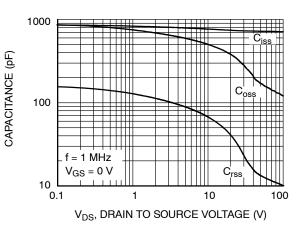


Figure 8. Capacitance vs. Drain to Source Voltage

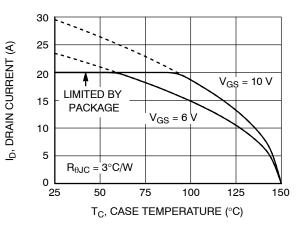


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

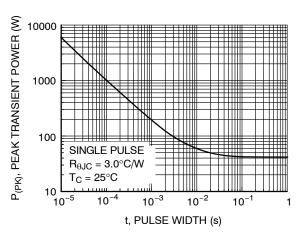


Figure 12. Single Pulse Maximum Power Dissipation

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TYPICAL CHARACTERISTICS (continued)

(T_J = 25°C unless otherwise noted)

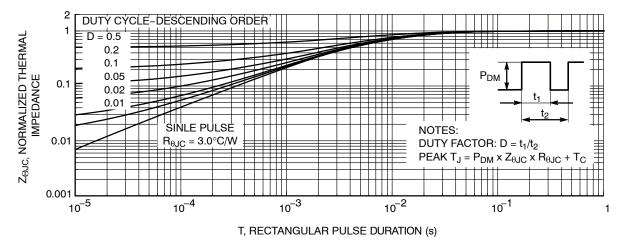
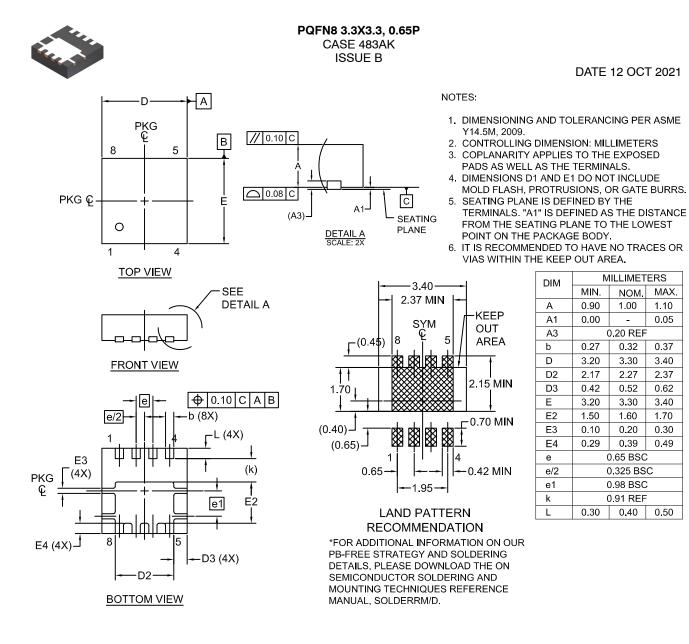


Figure 13. Transient Thermal Response Curve

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